Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | ONISHI ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | Α | US-5,253,487 | 10-1993 | Oike, Hiroshi | 62/353 |
| | В | US-5,400,605 | 03-1995 | Jeong, Sung-Ki | 62/72 |
| | С | US-5,617,728 | 04-1997 | Kim et al. | 62/71 |
| | D | US-5,970,725 | 10-1999 | Lee, Yong-Kweon | 62/137 |
| | E | US-6,058,720 | 05-2000 | Ryu, Gang | 62/135 |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | ρ | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | |
|---|---|---|--|
| | U | | |
| | v | | |
| | w | | |
| | х | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.